


• General Description

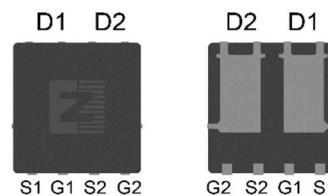
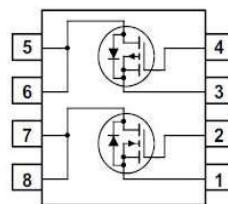
The ZMC88305N combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. It combines one N Channel MOSFET and one P channel MOSFET.

• Features

- Advance high cell density Trench technology
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Dual DIE in one package

• Product Summary

$V_{DS1} = 30V$
 $V_{DS2} = -30V$
 $R_{DS(ON)1} = 22m\Omega$
 $R_{DS(ON)2} = 30m\Omega$
 $I_{D1} = 15A$
 $I_{D2} = -14A$



DFN5*6

• Application

- Power Management in Notebook Computer
- BLDC Motor driver

• Ordering Information:

Part NO.	ZMC88305N
Marking	ZMC88305
Packing Information	REEL TAPE
Basic ordering unit (pcs)	3000

• N Channel Absolute Maximum Ratings ($T_c = 25^\circ C$)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	$I_D @ T_c = 25^\circ C$	15	A
	$I_D @ T_c = 75^\circ C$	11.4	A
	$I_D @ T_c = 100^\circ C$	9.5	A
Pulsed Drain Current ^①	I_{DM}	45	A
Total Power Dissipation	$P_D @ T_c = 25^\circ C$	43	W
Total Power Dissipation	$P_D @ T_A = 25^\circ C$	2.3	W
Operating Junction Temperature	T_J	-55 to 150	$^\circ C$
Storage Temperature	T_{STG}	-55 to 150	$^\circ C$
Single Pulse Avalanche Energy	E_{AS}	6	mJ


•P Channel Absolute Maximum Ratings ($T_c = 25^\circ\text{C}$)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	$I_D @ T_C = 25^\circ\text{C}$	-14	A
	$I_D @ T_C = 75^\circ\text{C}$	-10.6	A
	$I_D @ T_C = 100^\circ\text{C}$	-8.8	A
Pulsed Drain Current ⁽¹⁾	I_{DM}	-42	A
Total Power Dissipation	$P_D @ T_C = 25^\circ\text{C}$	43	W
Total Power Dissipation	$P_D @ T_A = 25^\circ\text{C}$	2.3	W
Operating Junction Temperature	T_J	-55 to 150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 to 150	$^\circ\text{C}$
Single Pulse Avalanche Energy	E_{AS}	35	mJ

•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R_{thJC}	-	-	2.9	$^\circ\text{C}/\text{W}$
Thermal resistance, junction - ambient	R_{thJA}	-	-	53	$^\circ\text{C}/\text{W}$
Soldering temperature, wavesoldering for 10s	T_{sold}	-	-	265	$^\circ\text{C}$

•N Channel Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0\text{V}$, $I_D = 250\mu\text{A}$	30			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}$, $I_D = 250\mu\text{A}$	1.2	1.6	2.5	V
Drain-Source Leakage Current	I_{DSS}	$V_{DS} = 30\text{V}$, $V_{GS} = 0\text{V}$			1.0	μA
Gate- Source Leakage Current	I_{GSS}	$V_{GS} = \pm 20\text{V}$, $V_{DS} = 0\text{V}$			± 100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS} = 10\text{V}$, $I_D = 6\text{A}$		22	29	$\text{m}\Omega$
		$V_{GS} = 4.5\text{V}$, $I_D = 4\text{A}$		30	40	$\text{m}\Omega$
Forward Transconductance	g_{FS}	$V_{DS} = 25\text{V}$, $I_D = 5\text{A}$		2		s


•Dynamic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Gate Resistance	R _g	f = 1MHz		1.5		Ω
Input capacitance	C _{iss}	f = 1MHz V _{DS} =25V	-	280	-	pF
Output capacitance	C _{oss}		-	46	-	
Reverse transfer capacitance	C _{rss}		-	25	-	
Total gate charge	Q _g	V _{DD} = 15V I _D = 6A V _{GS} = 10V	-	5.3	-	nC
Gate - Source charge	Q _{gs}		-	1.4	-	
Gate - Drain charge	Q _{gd}		-	0.8	-	

•P Channel Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =-250uA	-30			V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D =-250uA	-1.2		-2.5	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =-30V, V _{GS} =0V			-1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V			±100	nA
Static Drain-source On Resistance	R _{DS(ON)}	V _{GS} =-10V, I _D =-6A		30	42	mΩ
		V _{GS} =-4.5V, I _D =-4A		44	60	mΩ
Forward Transconductance	g _{FS}	V _{DS} =-10V, I _D =-5A		1.5		s

•Dynamic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Gate Resistance	R _g	f = 1MHz		10		Ω
Input capacitance	C _{iss}	f = 1MHz V _{DS} =-25V	-	850	-	pF
Output capacitance	C _{oss}		-	125	-	
Reverse transfer capacitance	C _{rss}		-	115	-	
Total gate charge	Q _g	V _{DD} = -15V I _D = -6A V _{GS} = -10V	-	12	-	nC
Gate - Source charge	Q _{gs}		-	5	-	
Gate - Drain charge	Q _{gd}		-	6	-	

**•N Channel characteristics curve**

Fig.1 Power Dissipation

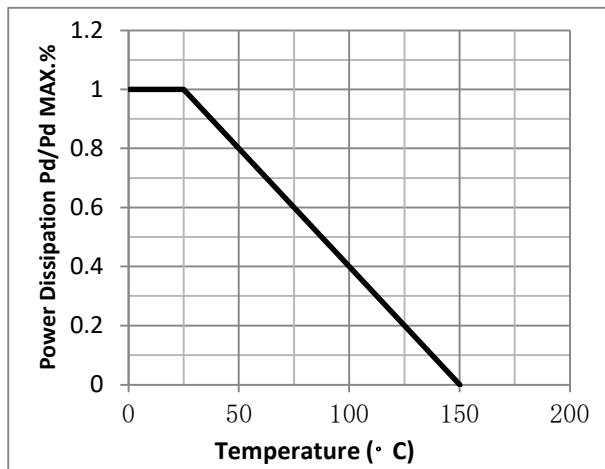


Fig.2 Typical output Characteristics

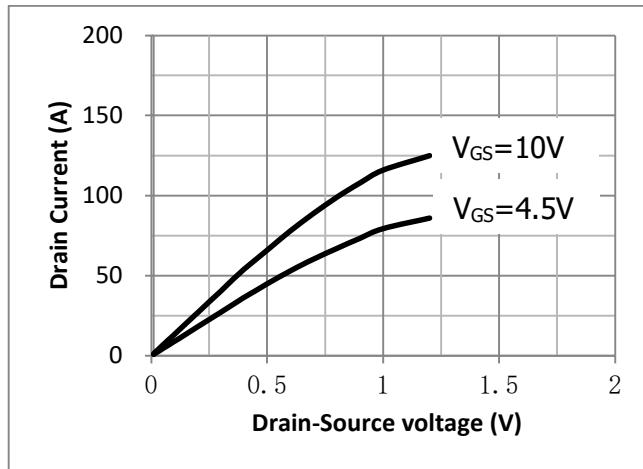


Fig.3 Threshold Voltage V.S Junction Temperature

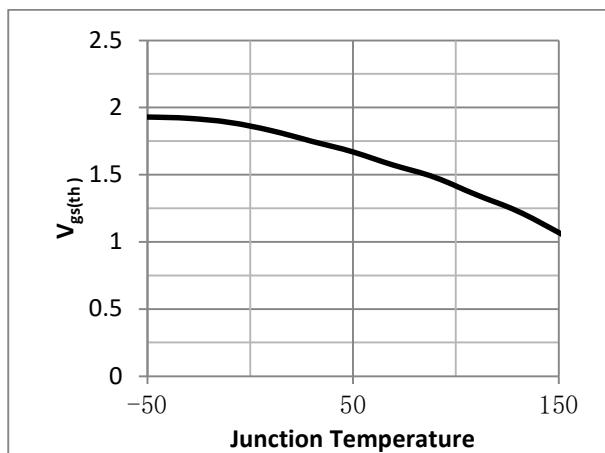


Fig.4 Resistance V.S Drain Current

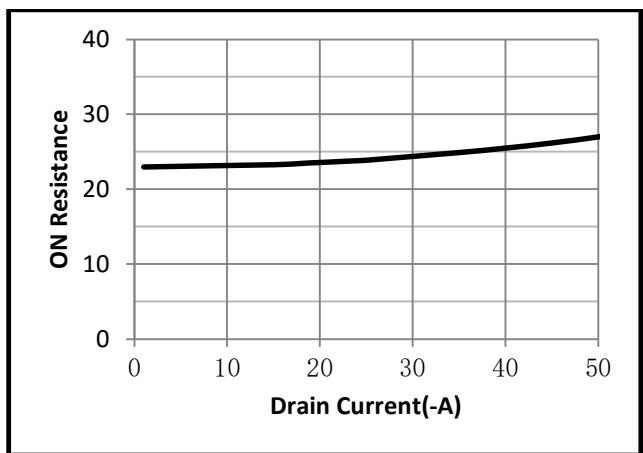


Fig.5 On-Resistance VS Gate Source Voltage

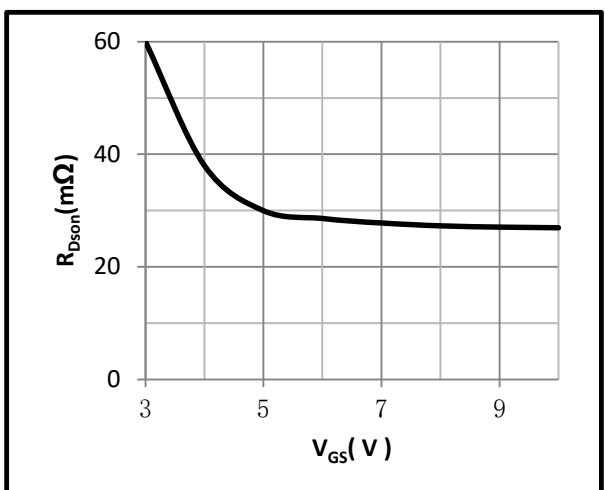
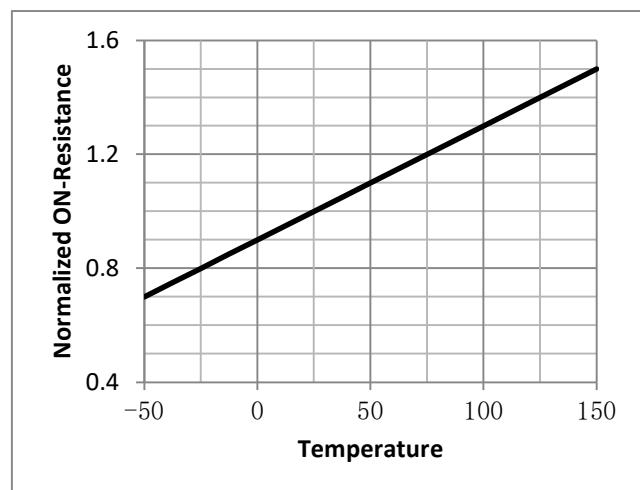


Fig.6 On-Resistance V.S Junction Temperature



**•P Channel characteristics curve**

Fig.1 Power Dissipation Derating Curve

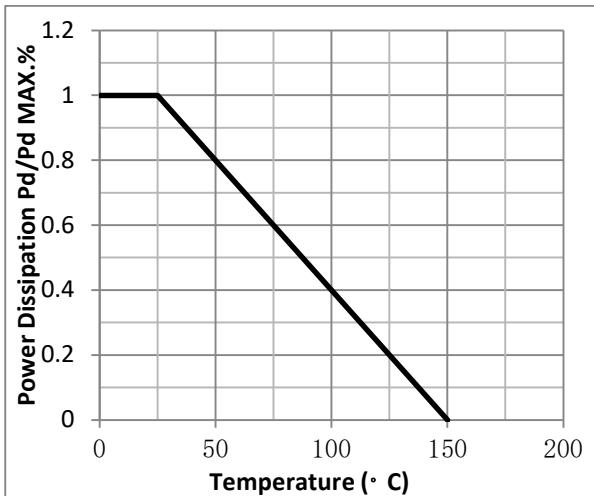


Fig.2 Typical output Characteristics

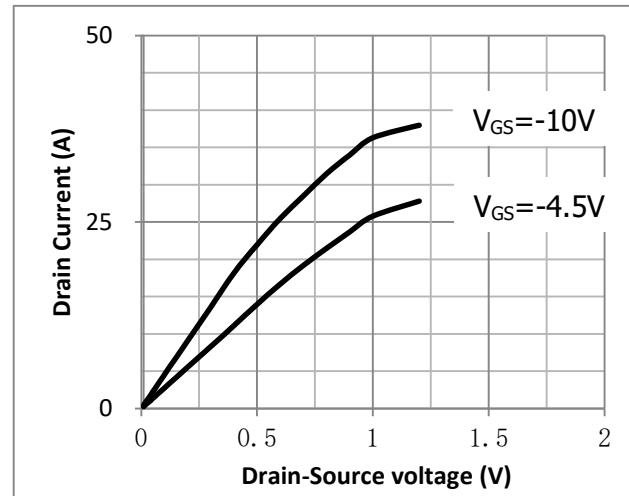


Fig.3 Threshold Voltage V.S Junction Temperature

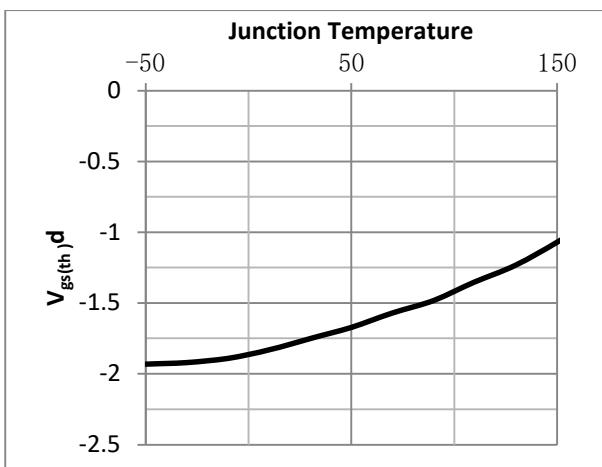


Fig.4 Resistance V.S Drain Current

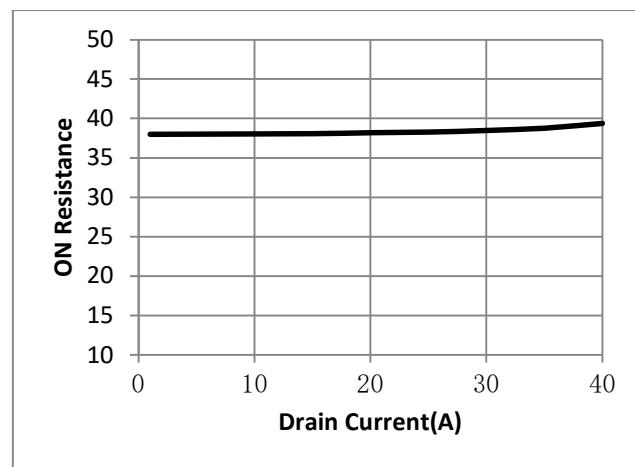


Fig.5 On-Resistance VS Gate Source Voltage

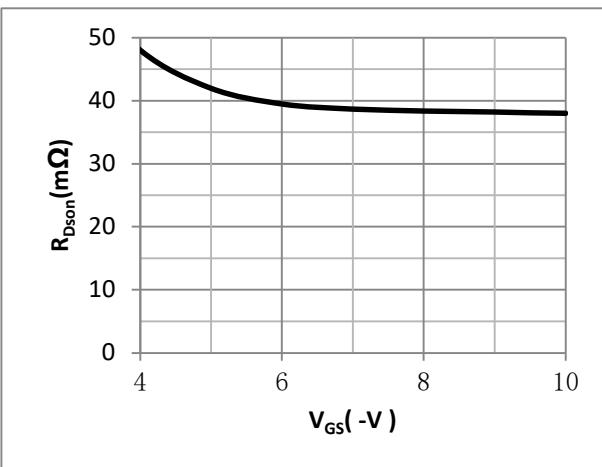
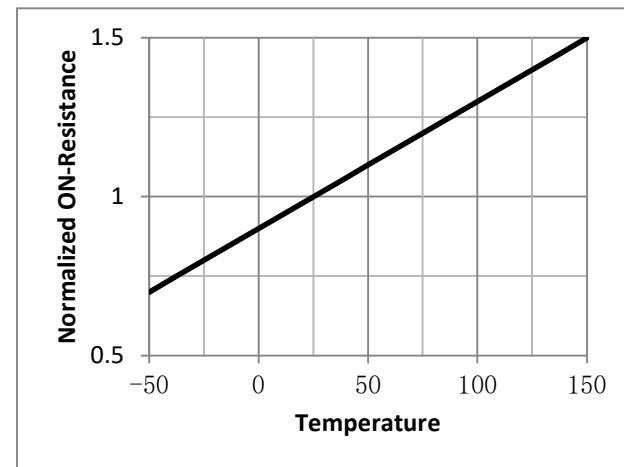


Fig.6 On-Resistance V.S Junction Temperature



**•Test Circuit**

Fig.1 Gate Charge Measurement Circuit

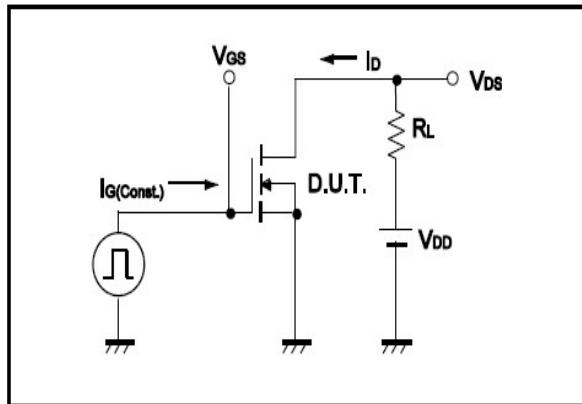


Fig.2 Gate Charge Waveform

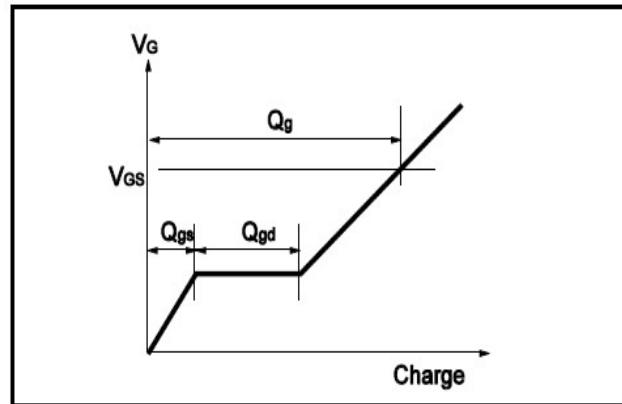


Fig.3 Switching Time Measurement Circuit

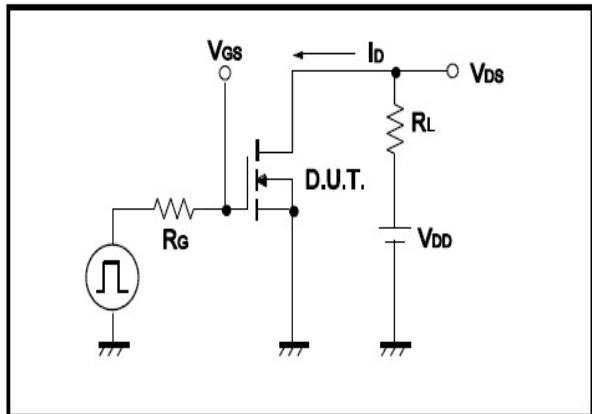


Fig.4 Switching Time Waveform

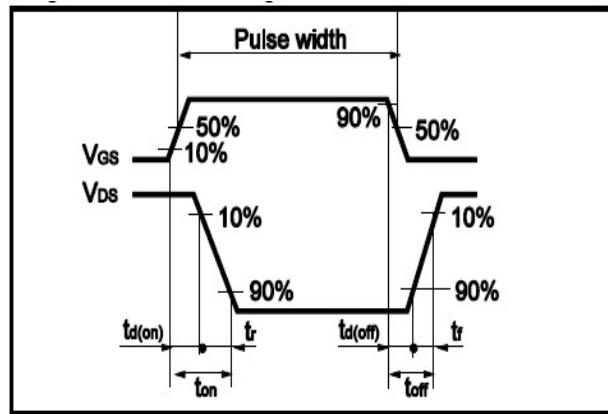


Fig.5 Avalanche Measurement Circuit

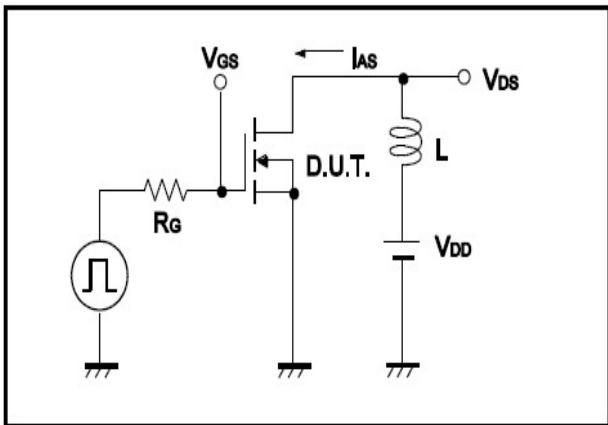
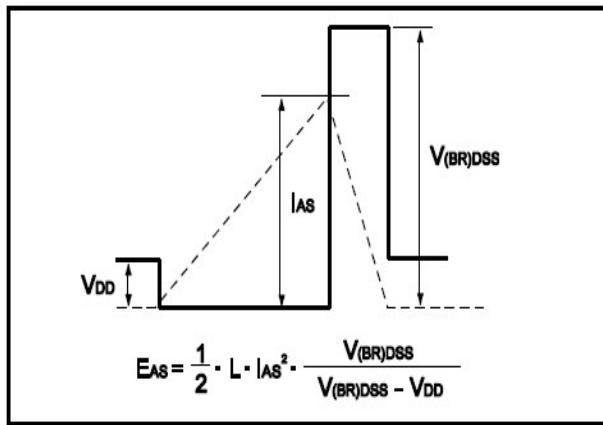


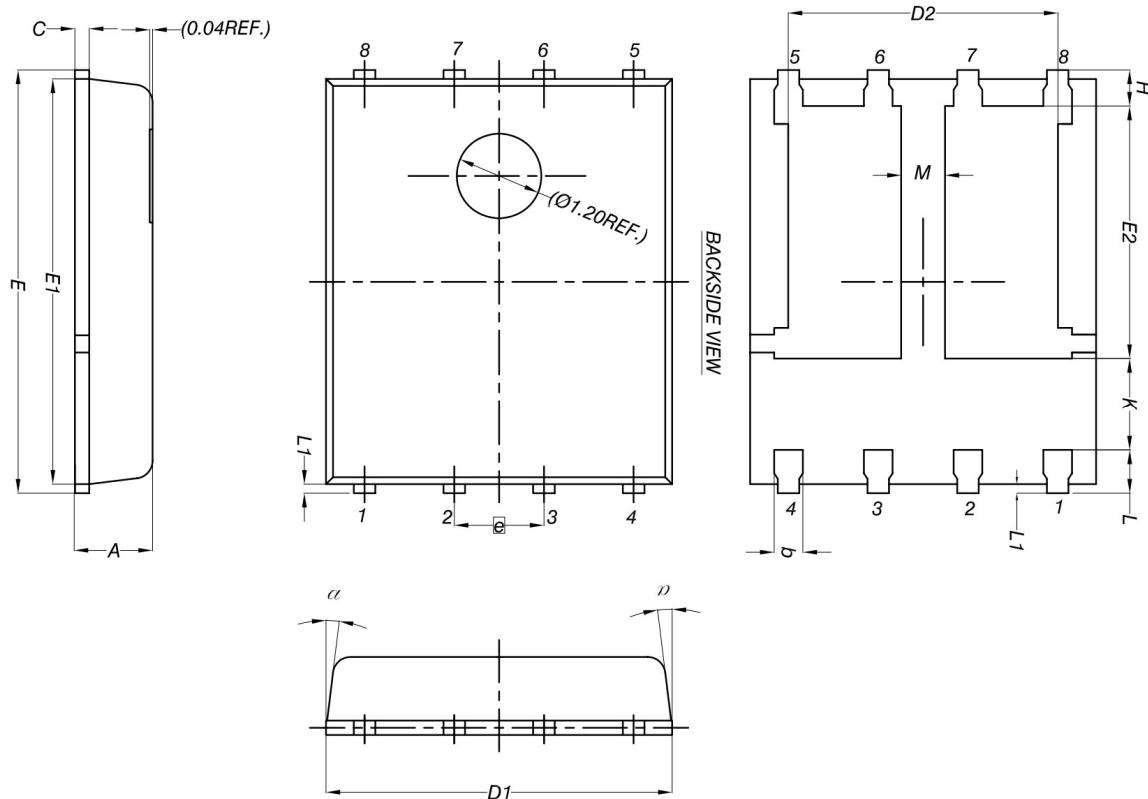
Fig.6 Avalanche Waveform





•Dimensions (DFN5x6)

Unit: mm



DIM.	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.90	1.00	1.10
b	0.33	0.41	0.51
C	0.20	0.25	0.30
D1	4.80	4.90	5.00
D2	3.61	3.81	3.96
E	5.90	6.00	6.10
E1	5.70	5.75	5.80
E2	3.38	3.58	3.78
e 1.27 BSC			
H	0.41	0.51	0.61
K	1.10	-	-
L	0.51	0.61	0.71
L1	0.06	0.13	0.20
M	0.50	-	-
α	0°	-	12°

